Electrical Properties of BaTiO$_3$-based 0603/0.1µF/0.3mm Ceramics Decoupling Capacitor for Embedding in the PCB of 10G RF Transceiver Module

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Abstract – Multi-layer ceramic capacitors as decoupling capacitor were fabricated by dielectric composition with a high dielectric constant. The fabricated decoupling capacitors were embedded in the PCB of the 10G RF transceiver module and evaluated for the characteristics of electrical noise by the level of AC input voltage. In order to further improve the electrical properties of the BaTiO$_3$ based composite, glass frit, MgO, Y$_2$O$_3$, MnO, V$_2$O$_3$, BaCO$_3$, SiO$_2$, and Al$_2$O$_3$ were used as additives. The electrical properties of the composites were determined by various amounts of additives and optimum sintering temperature. As a result of the optimized composite, it was possible to obtain a density of 5.777g/cm$^3$, a dielectric constant of 1994, and an insulation resistance of 2.91 x 10$^{12}$Ω at an additive content of 5wt% and a sintering temperature of 1250°C. After forming a 2.5µm green sheet using the doctor blade method, a total of 77 layers were laminated and sintered at 1180 °C. A decoupling capacitor with a size of 0.6 mm (W) x 0.3 mm (L) x 0.3 mm (T) (width, length and thickness, respectively) and a capacitance of 100 nF was embedded using a PCB process for the 10G RF Transceiver modules. In the range of AC input voltage 400mV @ 500kHz to 2200mV @ 900kHz, the embedded 10G RF Transceiver modules evaluated that it has better electrical performance than the non-embedded modules.

Keywords: Embedded PCB, Decoupling capacitor, BaTiO$_3$, Dielectric properties, RF transceiver module.

1. Introduction

With the development of modern electronics, other related industries such as telecommunications and IoT (Internet of things) are growing rapidly. As communication devices such as smart phones are improved to become low-power, multifunctional, and high-speed devices, efforts are being made to reduce the influence of high-frequency noise generated in the AP (application processor). In order to reduce the noise due to high frequency, there is a tendency to embedding R, L and C passive elements and active device chips in the PCB substrate as shown in Fig. 1. [1] Particularly, passive devices, which occupy more than 50% of the total electronic circuit area, have mounted discrete chip resistors or discrete chip capacitors on the surface of the PCBs. Recently, PCBs incorporating passive elements such as resistors or capacitors are being developed on demand. [2] The optical transceiver module converts the optical signal into an electrical signal from an optical communication system such as a large-capacity router. The optical transceiver module consists of many components, including the LD driver, preamplifier, and passive components. [8] In an environment using high frequency, the optical transceiver is very sensitive to electrical noise. This is because it uses a lot of parts on the PCB, which has a big influence on the high frequency.

In this study, a decoupling capacitor with a multilayer ceramic capacitor (MLCC) structure was fabricated using the optimized BaTiO$_3$ composition in sintering conditions and electrical characteristics were investigated. The

Fig. 1. Schematic diagram of embedding technologies inside a PCB
fabricated decoupling capacitor has a size of 0.6mm(W) × 0.3mm(L) × 0.3mm(T), a capacitance of 100nF and a temperature characteristic of X5R. It used Ni as the internal electrode and Cu as an external electrode. 10G RF transceiver modules using the fabricated decoupling capacitors were fabricated by the embedding PCB process such as lamination, via processing, plating and circuit formation. To improve the properties of electrical noise, the decoupling capacitor was placed directly beneath the IC terminal, which plays an important role in the 10G RF transceiver modules, to minimize the length of the electrical circuit. And 10G RF transceiver module fabricated by embedded PCB were measured the characteristics of the electrical noise and evaluated that it has better electrical performance than the non-embedded product.

2. Experimental Details

2.1 Fabrication of decoupling capacitor with a structure of MLCC

A BaTiO$_3$ powder (size: 170 nm) that was prepared by the hydrothermal method was used to fabricate a ceramic capacitor. Glass frit, MgO, Y$_2$O$_3$, Mn$_2$O$_3$, V$_2$O$_5$, BaCO$_3$, SiO$_2$ and Al$_2$O$_3$ were added to inhibit grain growth, accelerate low-temperature sintering, reduce resistance and improve reliability. Zirconia balls and law materials were added according to the compositions and mixed and pulverized using a bead mill for 24 hours. MLCC were fabricated using a multilayer chip ceramic process described in detail elsewhere. [6,7] The slurry for the preparation of the green sheet was mixed with the ceramic raw materials, dispersing agents and solvent (toluene / ethanol) at an appropriate ratio and then mixed and dispersed for 8 hours using a basket mill. The slurry was further processed by adding PVB (Sekisui, BM-SZ) and DOP (DC chemical) to the mixed and dispersed slurry in an appropriate blending ratio for 4 hours, and a 2.5 μm green sheet was then formed using the doctor blade method. The green sheet was then printed with Ni paste, and 77 layers were laminated, followed by compression and cutting to produce a laminated chip having dimensions of 0.6x0.3x0.3mm. The laminated chips were degreased at 250 °C for 48 hours and then fired at 1140 °C, 1160 °C and 1180 °C for 2 hours under H$_2$ partial pressures of 10-11 MPa using a mixture of H$_2$-N$_2$-H$_2$O gases. To improve the reliability of MLCC, the reformation heat treatment was performed at 900 °C and PO$_2$ = 10$^{-7}$ MPa for 2 hours. The external electrodes were fired using a Cu electrode after polishing so that the internal electrodes were left out of the fired chip. The dielectric property was measured at 1 kHz and 1Vrms using an LCR meter (HP4278A, HP, USA). Insulation resistance was measured with a high resistance meter (HP4339B, HP, USA).

2.2 Fabrication of a 10G RF transceiver module

The 10G RF transceiver module is designed to embedding the 0603 MLCC (capacitance: 100nF, thickness: 0.3mm) in the PCB. MLCC as decoupling capacitor were embedded in 2-3 layers and 5-6 layers with 6 layer of PCB and the total thickness of about 1mm. The size of 0.6mm(W) × 0.3mm(L) × 0.3mm(T) were embedded by using PCB process in sequence such as lamination, via processing, plating and circuit formation. [9] To improve the properties of electrical noise in high frequency, MLCC was placed directly beneath the IC terminal, which plays an important role in the 10G RF transceiver modules, to minimize the length of the electrical circuit. The external electrode of the MLCC was coated with a Cu material, and its width was 300μm and its length was 200μm. Via was formed by using CO$_2$ laser to electrically connect to external IC from embedded MLCC in PCB. The size of a formed via is 100μm on the top and 70μm on the bottom. To fill Cu in the formed via, via were filled using electroless/electrolytic plating. Thus, the embedded MLCC is electrically connected to the outermost layer of the PCB and can be used as a passive component on the module. In order to operate a 10G RF transceiver module electrically, other passive components and active components were equipped on the 1st and 6th layers of PCB using the SMT process.

3. Results and Discussion

3.1 Dielectric properties according to additive and sintering temperature

Fig. 2 shows the XRD results with various amounts of additive at a sintering temperature of 1260 °C. As the proportion of additives increases, the main peak shifts slightly to a higher angle. The shift of the main peak to the higher angle is likely due to the increase in the lattice volume of the pseudo-cubic crystal phase as the additive

![Fig. 2. XRD patterns of BaTiO$_3$ specimens with various additive contents: (a) 3 wt.%; (b) 4 wt.%; (c) 5 wt.%; (d) 6 wt.%](http://www.jeet.or.kr)
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Fig. 3. Bulk Density of BaTiO3 specimens as a function of additive contents and sintering temperature

Fig. 4. Dielectric constant of BaTiO3 specimens as a function of additive contents and sintering temperature

Fig. 5. Insulation resistance as a function of additive content and sintering temperature

Fig. 6. Optical image of MLCC as a function of sintering temperature

Fig. 7. SEM image of MLCC as a function of sintering temperature (a) 1140 °C and (b) 1160 °C

BaTiO3 [10] Above 1225 °C, the insulation resistance was more than 1×10^{12} \Omega as expected due to the compensation of the atoms by the additive.[11]

3.2 Characteristics of decoupling capacitor with a structure of MLCC

Fig. 6 is an optical microscope photograph of a multilayer ceramic chip capacitor produced by forming a green chip having BaTiO3 as a main component and having an added amount of 4 wt%. The sintering temperatures are 1140 °C (a), 1160 °C (b) and 1180 °C (c). It can be seen that the electrode coverage rate increases with increasing sintering temperature. As seen in the 1180 °C image, a broken electrode is observed.

Fig. 7 shows a cross section of a multilayer chip ceramic capacitor by an electron microscope (SEM). The electrode coverage rate is 72% at 1140 °C, increased to 92% at 1160 °C. Fig. 8 is a photograph of the internal cross-
sectional structure of a multilayer ceramic capacitor obtained by baking at 1160 °C and 1180 °C with BaTiO₃ as a main component and adding 4 wt% of additives. As shown in the microstructure, the particle size is 150 to 400 μm, and uniform internal and external electrodes are shown.

3.3 Noise characteristics of 10 G RF transceiver module

Fig. 9 is a circuit diagram designed to embedding MLCC with 0603 size and 0.3mm thickness, 100 nF capacitance in the PCB inner layer. The embedding position of the MLCC on modules is shown.

Fig. 8. Sectional SEM image of MLCC

Fig. 9. Embedded location of decoupling capacitor in 6-layer PCB. (a) L2-L3 Layer (b) L4-L5 Layer

Fig. 10 shows a cross-section and an X-ray image for the embedded MLCC in a 1mm of PCB thickness. Fig. 11 shows a fabricated 10G RF transceiver module with dimensions of 330 × 250mm. The IC and the passive components are mounted on embedded PCB by SMT processing. On the front, there is an MCU that can control the transmitter and receiver. On the rear, there is a circuit that can operate the transmitter and the receiver.

Fig. 11(a) consists of a circuit for driving the transmitter and the receiver. Fig. 11(b) shows the MCU attached to control the module. To match the circuit to the 10G signal frequency, the I/O terminal circuit has an impedance match of 50 Ω.

Fig. 12 shows the AC input voltage (mmVp-p) depending on the frequency for the MLCC embedded and non-embedded 10G transceiver modules. A high value of voltage or AC level means that there is more noise on the input power supply. A large value of the measured input noise means that the module operates normally up to the AC input voltage of the measured electrical noise. Therefore, by applying AC input voltage as noise to the input of the module, it is possible to evaluate the performance of the product whether the 10G Transceiver...
module operates normally or abnormally at an arbitrary input voltage. In the range of AC input voltage 400mV @ 500kHz to 2200mV @ 900kHz, the embedded module evaluated that it has better electrical performance than the non-embedded product. [12,13]

4. Conclusion

In this study, A BaTiO₃ powder (size:170nm) that was prepared by the hydrothermal method was used to fabricate a ceramic capacitor. Glass frit, MgO, Y₂O₃, Mn₃O₄, V₂O₅, BaCO₃, SiO₂ and Al₂O₃ were added to inhibit grain growth, accelerate low-temperature sintering, reduce resistance and improve reliability. The shift of the main peak to the higher angle is likely due to the increase in the lattice volume of the pseudo-cubic crystal phase as the additive diffuses into the cubic + tetragonal structure of BaTiO₃. The density tends to increase with increasing sintering temperature regardless of the amount of additive. Therefore, although the density is affected by the temperature, there is no significant influence depending on the proportion of the additive. The dielectric constant increases as the proportion of the additive increases. This phenomenon is due to the increased presence of additives in the core shell structure. At 1200°C, the specimens showed low insulation resistance due to the decrease in sintering density, and insulation is well known to be affected by the crystal phase and sinterability of BaTiO₃. Above 1225°C, the insulation resistance was more than 1×10¹²Ω as expected due to the compensation of the atoms by the additive.

Therefore, the fabricated MLCC is applied as a structure optimized for embedded PCB. Embedded MLCC using the process of the embedded PCB for 10 RF transceiver modules has reduced the circuit length to IC compared to circuit length of existing SMT parts. As a result, the embedded and fabricated modules evaluated that they have better electrical performance than the non-embedded products in the AC input voltage range of 400mV @ 500 kHz to 2200mV @ 900kHz.

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